

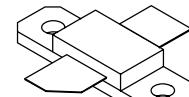
**The RF Sub-Micron MOSFET Line**  
**RF Power Field Effect Transistors**  
**N-Channel Enhancement-Mode Lateral MOSFETs**

Designed for broadband commercial and industrial applications with frequencies up to 1.0 GHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 26 volt base station equipment.

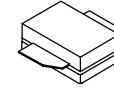
- Typical Two-Tone Performance at 945 MHz, 26 Volts
  - Output Power — 30 Watts PEP
  - Power Gain — 19 dB
  - Efficiency — 41.5%
  - IMD — -32.5 dBc
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 10:1 VSWR, @ 26 Vdc, 945 MHz, 30 Watts CW Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- In Tape and Reel. R1 Suffix = 500 Units per 32 mm, 13 inch Reel.
- Low Gold Plating Thickness on Leads. L Suffix Indicates 40 $\mu$ " Nominal.

**MRF9030LR1**  
**MRF9030LSR1**

945 MHz, 30 W, 26 V  
 LATERAL N-CHANNEL  
 BROADBAND  
 RF POWER MOSFETs



CASE 360B-05, STYLE 1  
 NI-360  
 MRF9030LR1



CASE 360C-05, STYLE 1  
 NI-360S  
 MRF9030LSR1

#### MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	68	Vdc
Gate-Source Voltage	V <sub>GS</sub>	- 0.5, + 15	Vdc
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	92 0.53 117 0.67	Watts W/°C
Storage Temperature Range	T <sub>stg</sub>	- 65 to +150	°C
Operating Junction Temperature	T <sub>J</sub>	200	°C

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	1.9 1.5	°C/W

#### ESD PROTECTION CHARACTERISTICS

Test Conditions	Class
Human Body Model	1 (Minimum)
Machine Model	M1 (Minimum)

NOTE - **CAUTION** - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

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ELECTRICAL CHARACTERISTICS ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>					
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 68 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 26 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5 \text{ Vdc}$ , $V_{DS} = 0 \text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$
<b>ON CHARACTERISTICS</b>					
Gate Threshold Voltage ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 100 \mu\text{Adc}$ )	$V_{GS(\text{th})}$	2	2.9	4	$\text{Vdc}$
Gate Quiescent Voltage ( $V_{DS} = 26 \text{ Vdc}$ , $I_D = 250 \text{ mA dc}$ )	$V_{GS(Q)}$	—	3.8	—	$\text{Vdc}$
Drain-Source On-Voltage ( $V_{GS} = 10 \text{ Vdc}$ , $I_D = 0.7 \text{ Adc}$ )	$V_{DS(\text{on})}$	—	0.19	0.4	$\text{Vdc}$
Forward Transconductance ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 2 \text{ Adc}$ )	$g_{fs}$	—	3	—	S
<b>DYNAMIC CHARACTERISTICS</b>					
Input Capacitance ( $V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0 \text{ Vdc}$ )	$C_{iss}$	—	49.5	—	pF
Output Capacitance ( $V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0 \text{ Vdc}$ )	$C_{oss}$	—	26.5	—	pF
Reverse Transfer Capacitance ( $V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0 \text{ Vdc}$ )	$C_{rss}$	—	1	—	pF

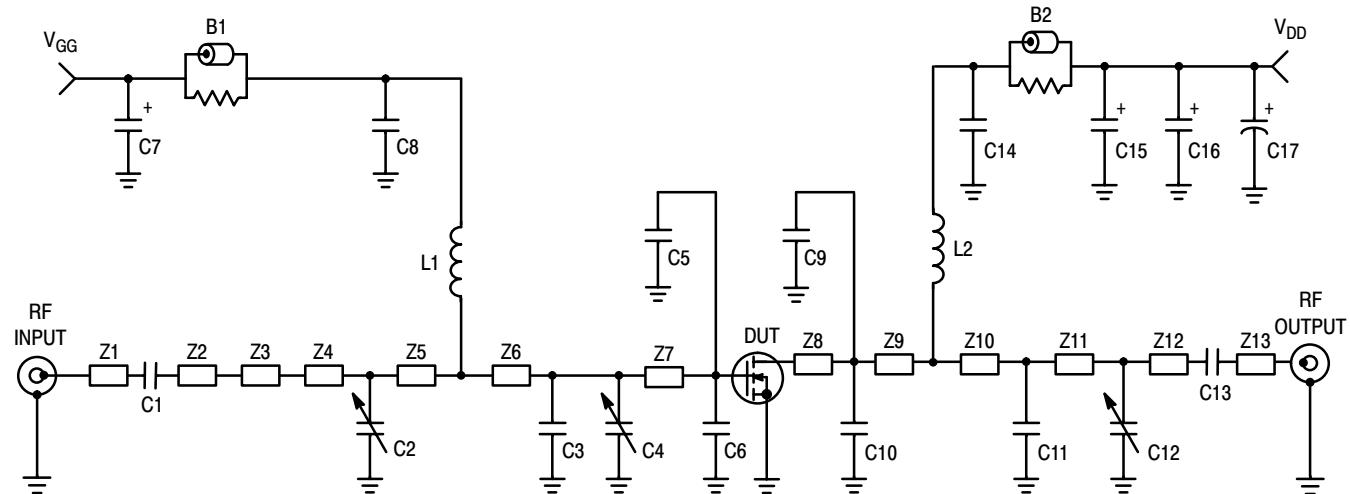
(continued)

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**ELECTRICAL CHARACTERISTICS — continued** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>FUNCTIONAL TESTS</b> (In Motorola Test Fixture, 50 ohm system)					
Two-Tone Common-Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ , $f_2 = 945.1 \text{ MHz}$ )	$G_{ps}$	18	19	—	dB
Two-Tone Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ , $f_2 = 945.1 \text{ MHz}$ )	$\eta$	37	41.5	—	%
3rd Order Intermodulation Distortion ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ , $f_2 = 945.1 \text{ MHz}$ )	IMD	—	-32.5	-28	dBc
Input Return Loss ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ , $f_2 = 945.1 \text{ MHz}$ )	IRL	—	-15.5	-9	dB
Two-Tone Common-Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 930.0 \text{ MHz}$ , $f_2 = 930.1 \text{ MHz}$ and $f_1 = 960.0 \text{ MHz}$ , $f_2 = 960.1 \text{ MHz}$ )	$G_{ps}$	—	19	—	dB
Two-Tone Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 930.0 \text{ MHz}$ , $f_2 = 930.1 \text{ MHz}$ and $f_1 = 960.0 \text{ MHz}$ , $f_2 = 960.1 \text{ MHz}$ )	$\eta$	—	41.5	—	%
3rd Order Intermodulation Distortion ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 930.0 \text{ MHz}$ , $f_2 = 930.1 \text{ MHz}$ and $f_1 = 960.0 \text{ MHz}$ , $f_2 = 960.1 \text{ MHz}$ )	IMD	—	-33	—	dBc
Input Return Loss ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W PEP}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 930.0 \text{ MHz}$ , $f_2 = 930.1 \text{ MHz}$ and $f_1 = 960.0 \text{ MHz}$ , $f_2 = 960.1 \text{ MHz}$ )	IRL	—	-14	—	dB
Power Output, 1 dB Compression Point ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W CW}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ )	$P_{1\text{dB}}$	—	30	—	W
Common-Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W CW}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ )	$G_{ps}$	—	19	—	dB
Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W CW}$ , $I_{DQ} = 250 \text{ mA}$ , $f_1 = 945.0 \text{ MHz}$ )	$\eta$	—	60	—	%
Output Mismatch Stress ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 30 \text{ W CW}$ , $I_{DQ} = 250 \text{ mA}$ , $f = 945.0 \text{ MHz}$ , $\text{VSWR} = 10:1$ , All Phase Angles at Frequency of Tests)	$\Psi$	No Degradation In Output Power			

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B1 Short Ferrite Bead  
B2 Long Ferrite Bead

C1, C8, C13, C14 47 pF Chip Capacitors, B Case  
C2, C4 0.8 pF to 8.0 pF Trim Capacitors  
C3 3.9 pF Chip Capacitor, B Case  
C5, C6 7.5 pF Chip Capacitors, B Case  
C7, C15, C16 10  $\mu$ F, 35 V Tantalum Capacitors  
C9, C10 10 pF Chip Capacitors, B Case  
C11 9.1 pF Chip Capacitor, B Case  
C12 0.6 pF to 4.5 pF Trim Capacitor  
C17 220  $\mu$ F, 50 V Electrolytic Capacitor  
L1, L2 12.5 nH Surface Mount Inductors  
Z1 0.260" x 0.060" Microstrip  
Z2 0.240" x 0.060" Microstrip

Z3 0.500" x 0.100" Microstrip  
Z4 0.215" x 0.270" Microstrip  
Z5 0.315" x 0.270" Microstrip  
Z6 0.160" x 0.270" x 0.520", Taper  
Z7 0.285" x 0.520" Microstrip  
Z8 0.140" x 0.270" Microstrip  
Z9 0.450" x 0.270" Microstrip  
Z10 0.250" x 0.060" Microstrip  
Z11 0.720" x 0.060" Microstrip  
Z12 0.490" x 0.060" Microstrip  
Z13 0.290" x 0.060" Microstrip  
PCB Taconic RF-35-0300, 30 mil,  
 $\epsilon_r = 3.55$

Figure 1. 945 MHz Broadband Test Circuit Schematic

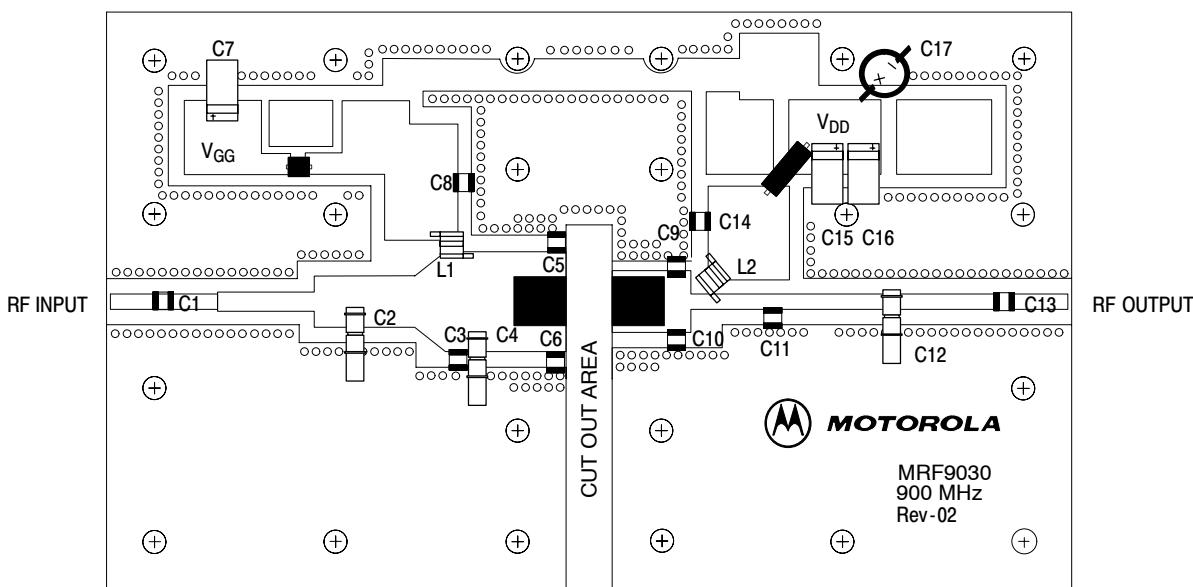
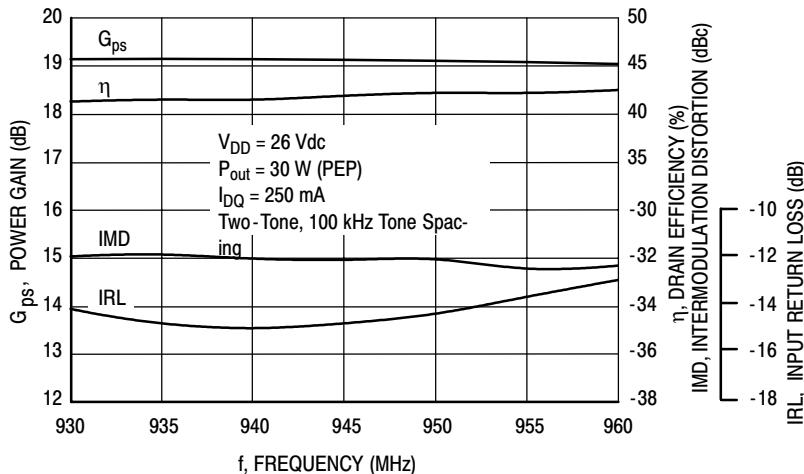


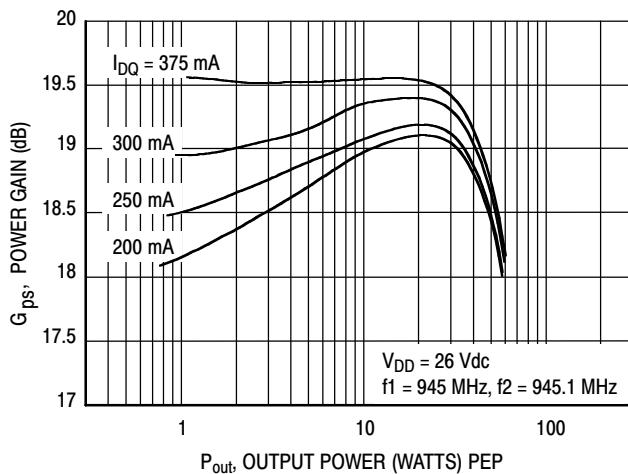
Figure 2. 945 MHz Broadband Test Circuit Component Layout

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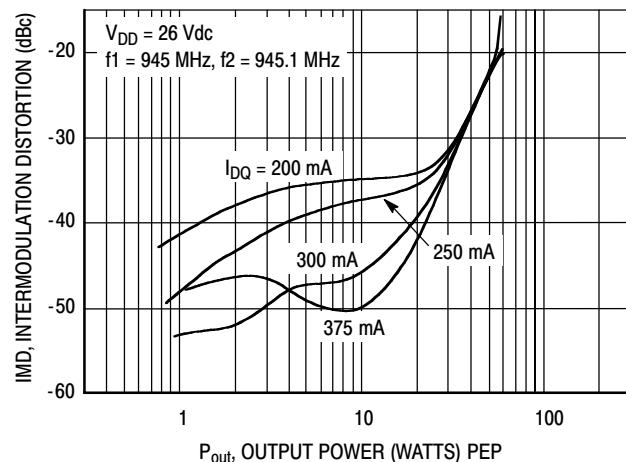
## TYPICAL CHARACTERISTICS



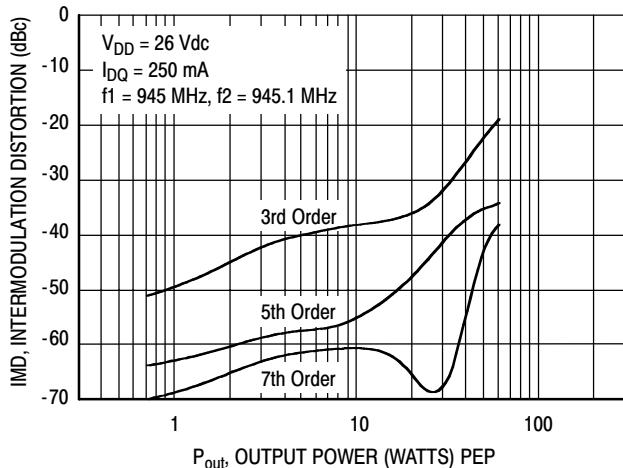
**Figure 3. Class AB Broadband Circuit Performance**



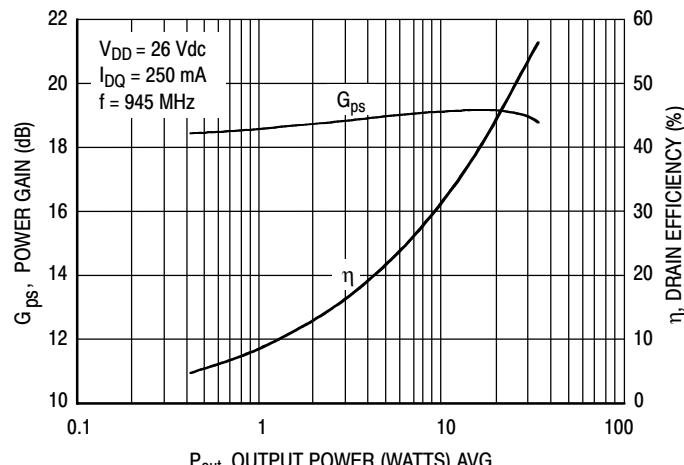
**Figure 4. Power Gain versus Output Power**



**Figure 5. Intermodulation Distortion versus Output Power**

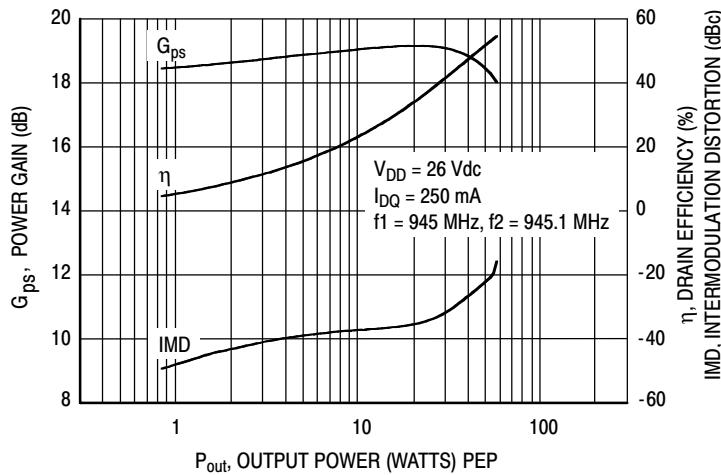


**Figure 6. Intermodulation Distortion Products versus Output Power**

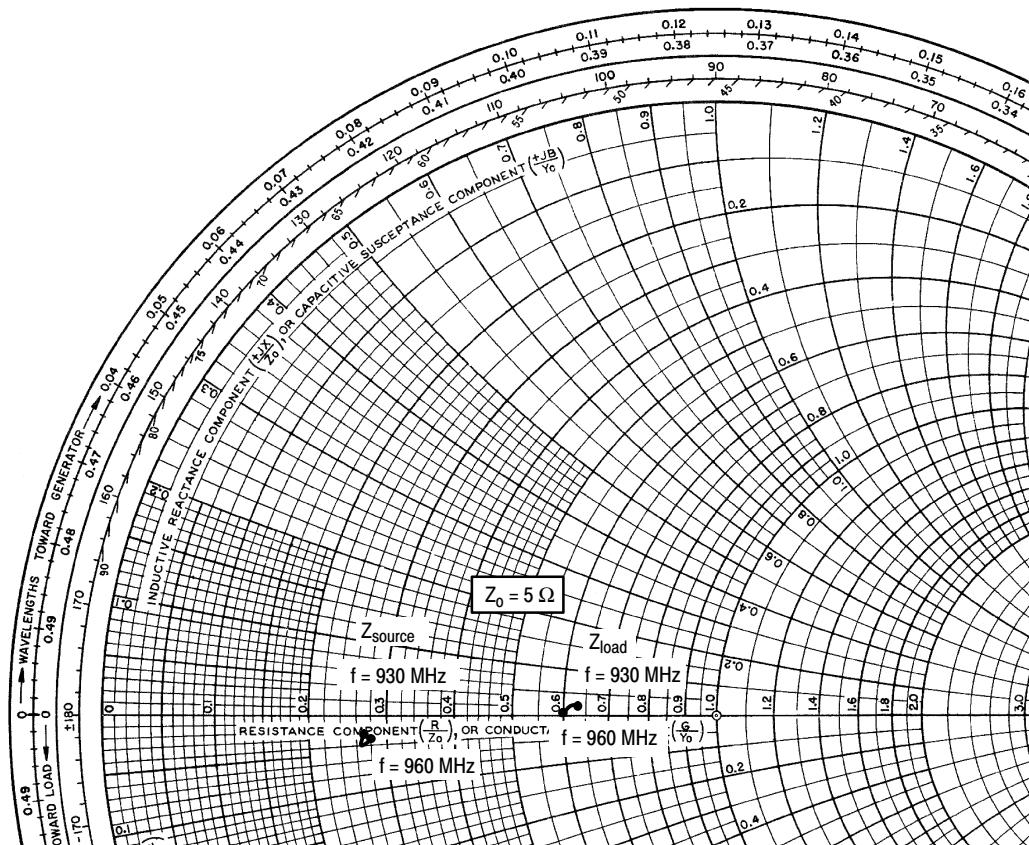


**Figure 7. Power Gain and Efficiency versus Output Power**

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**Figure 8. Power Gain, Efficiency and IMD  
versus Output Power**



$f$ MHz	$Z_{\text{source}}$ $\Omega$	$Z_{\text{load}}$ $\Omega$
930	$1.34 - j0.1$	$3.175 + j0.09$
945	$1.36 - j0.2$	$3.1 + j0.08$
960	$1.4 - j0.14$	$3.0 + j0.05$

$Z_{\text{source}}$  = Test circuit impedance as measured from gate to ground.

$Z_{\text{load}}$  = Test circuit impedance as measured from drain to ground.

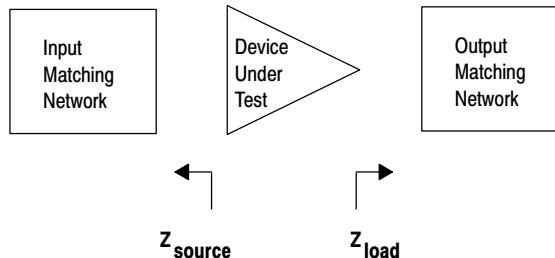


Figure 9. Series Equivalent Input and Output Impedance

**NOTES**

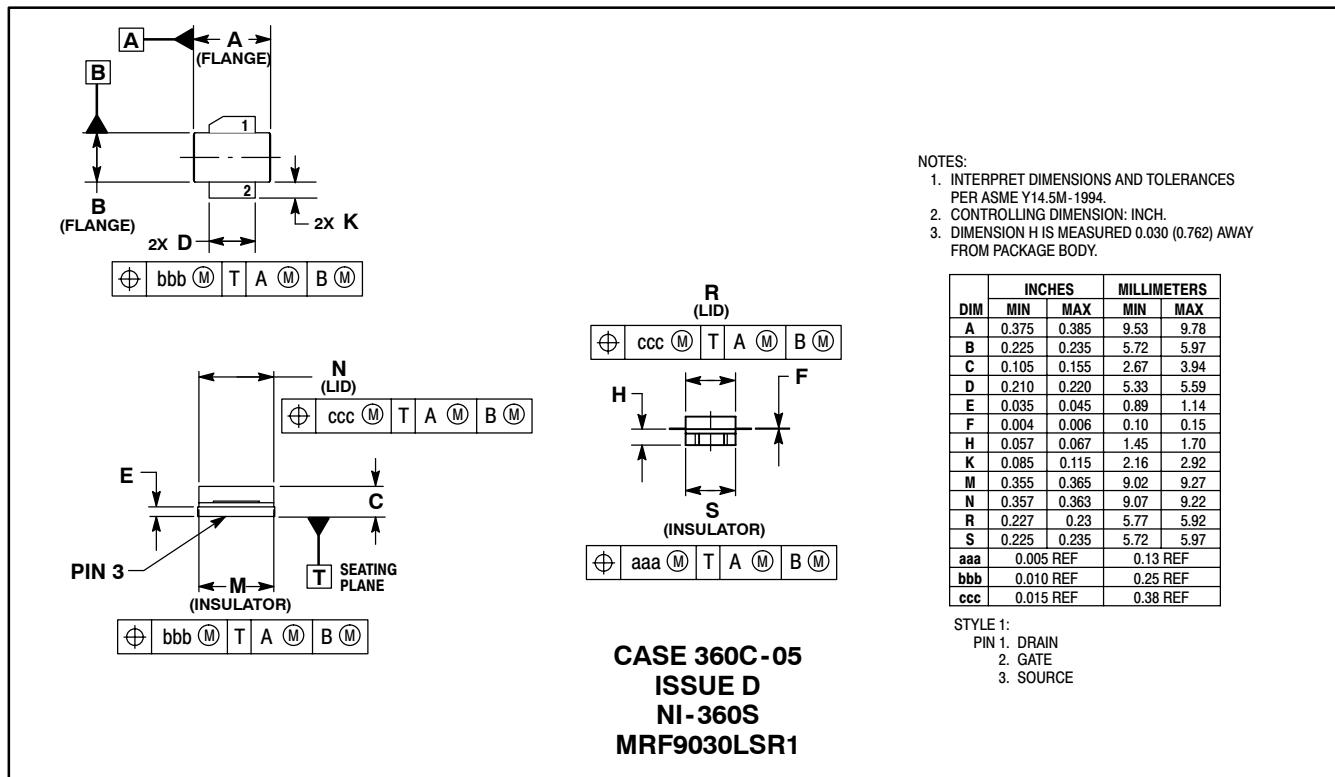
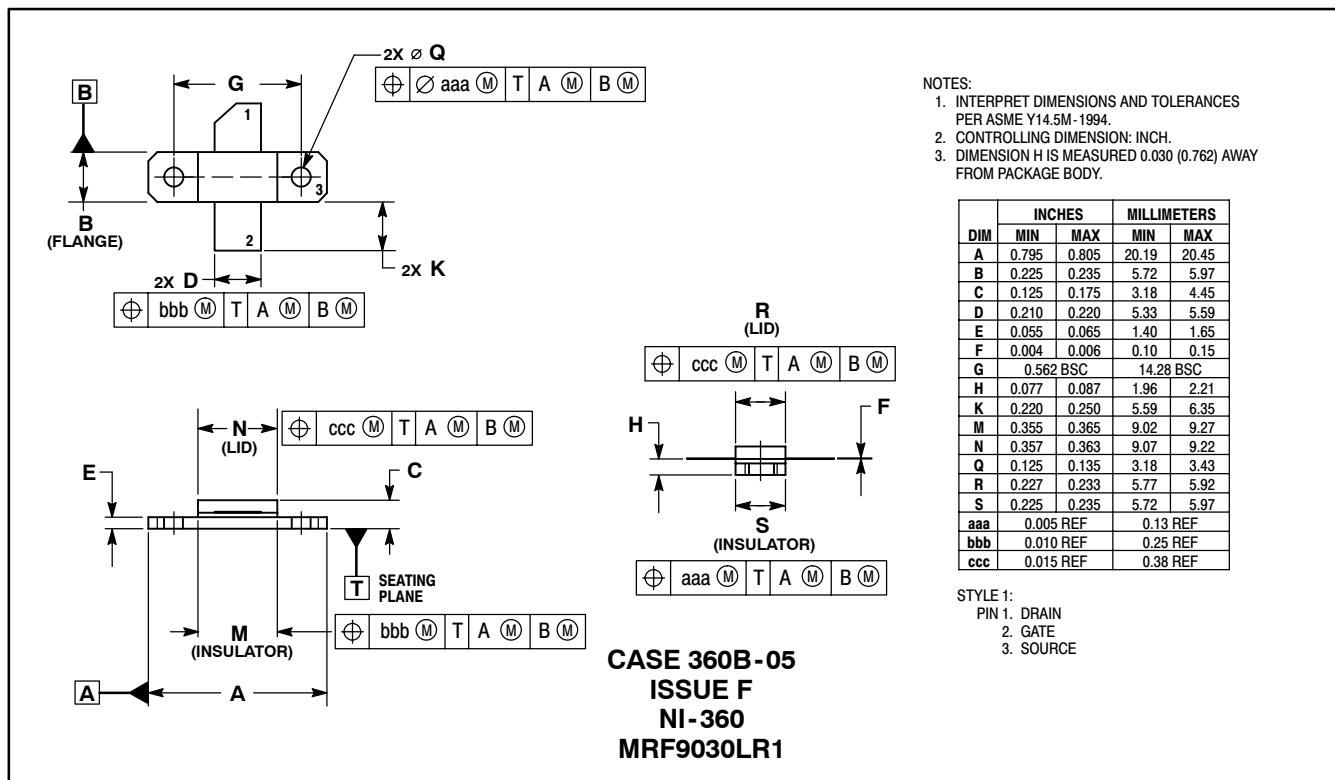
**NOTES**

**NOTES**

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## PACKAGE DIMENSIONS

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